SHEET 1 OF 2

A DEDUCTION OF COMMEDCE			ATTY DOCKET NO. SERIAL NO.					
Form PTO 1449 U.S. DEPARTMENT OF COMME (Modified) PATENT AND TRADEMARK OF		DEMARK OFFICE	254616US40PCT		09/101,833			
			APPLICANT CONTENTS OF THE PROPERTY OF THE PROP					
LIST OF	REFER	ENCES CITED BY AF	PPLICANT	Yasuji HIRAMATSU				
EIGT OF THE ENERGES STORES				FILING DATE		GROUP	1793	
				January 29, 1999		1793		
				U.S. PATENT DOCUMENTS				
	• -	DOCUMENT	1			SUB	FILI	NG DATE
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME CLASS				ROPRIATE
/G.E./	AA	4,708,545	11/24/1987	Fujii, et al.	-			
	AB	4,720,798	01/19/1988	Reed, et al.	<del> </del>	ļi		
	AC	5,073,687	12/17/1991	Inagawa, et al.				
	AD	5,111,406	05/05/1992	Zachman, et al.				
	AE	5,144,681	09/01/1992	Kitakado, et al.				
	AF	5,191,699	03/09/1993	Gansimeier, et al.				
	AG	5,294,975	03/15/1994	Norman, et al.				
	АН	5,337,151	08/09/1994	Baxter, et al.				
	AI	5,355,247	10/11/1994	Byer, et al.				
	AJ	5,393,359	02/28/1995	Chang, et al.				
	AK	5,401,909	03/28/1995	Arnold, et al.				
	AL	5,529,441	06/25/1996	Kosmowski, et al.	- I			
<b>₩</b>	AM	5,548,372	08/20/1996	Schroeder, et al.				
/G.E./	AN	5,655,030	08/05/1997	Suzuki				
1G.L./	1	0,000,000	FO	REIGN PATENT DOCUMENTS				
	· · · · · · · · · · · · · · · · · · ·	1	<u> </u>	I		T	TRANSLA	ATION
		DOCUMENT NUMBER	DATE	COUNTRY		YE		NO
/G.E./	AO	03-011571	01/18/1991	Japan w/English Abstract		ļ		X
1	AP	04-115517	04/16/1992	Japan w/English Abstract				×
	AQ	05-318160	12/03/1993	Japan w/English Abstract				×
	AR	06-120683	04/28/1994	Japan w/English Abstract		<u> </u>		X
	AS	06-269969	09/27/1994	Japan w/English Abstract				X
	AT	61-125715	06/13/1986	Japan w/English Abstract				Х
	AU	62-004503	01/10/1987	Japan w/English Abstract				Х
/G.E./	AV	62-024906	02/02/1987	Japan w/English Abstract				Х
, 5.2./		<u> </u>	EFERENCES (	Including Author, Title, Date, Pertine	nt Pages, e	tc.)		
	1	Tokono et al "LASE	R DRILLING by	HIGH PEAK LASER PULSED CO2 La	ser". Octob	er 1992, IC	CALEO La:	ser Materials
/G.E./	AW	Processing- Proceedi	ngs of SPIE, Ti	ne International Society of Optical Engir	neering, vol.	1990, pag	es 459-46	8.
	AX							
	AY							····
	<del>  '``</del>				1_		<del></del>	<del></del>
	AZ		Additional References sheet(s) attached					
Examiner	/Geof	frey Evans/		Date Considered 11/24/2007				
*Evenines:	oitial if	reference is considered	, whether or no	t citation is in conformance with MPEP with next communication to applicant.	609; Draw I	ine through	citation if	not in

Form PTO 1449 U.S. DEPARTMENT OF COMMERCE				ATTY DOCKET NO. 254616US40PCT		SERIAL NO. 09/101,833		
Modified) PATENT AND TRADEMARK OFFICE								
				APPLICANT				
LIST OF F	REFER	ENCES CITED BY AP	PLICANT	Yasuji HIRAMATSU				
				FILING DATE		GROUP 1703		
				January 29, 1999		1793		
				U.S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE		
/G.E./	AA	5,751,585	05/12/1998	Cutler, et al.				
1	AB	5,764,485	06/09/1998	Lebaschi				
	AC	5,780,807	07/14/1998	Saunders				
_	AD	5,841,099	11/24/1998	Owen, et al.				
	AE	6,091,026	07/18/2000	Yang				
<del>\</del>	AF	6.211,485	04/03/2001	Burgess	1			
	AG	5,266,380	11/30/1993	Renguso, et al.		<u> </u>	·	
/G.E./_		0,200,000			<del> </del>			<del></del>
	AH		<u> </u>		<del> </del>	-		
	AI		1		<u> </u>			
	AJ		<del> </del>		<del>                                     </del>			
	AK				<del> </del>			
	AL		<u> </u>		<u> </u>	<del> </del>		
	AM		<u> </u>		<del> </del>			
	AN				J	<u> </u>	L	
		•	FO	REIGN PATENT DOCUMENTS				
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO		
/G.E./	AO	61-020683	01/29/1986	Japan w/English Abstract		}		×
_/G.E./	AP							
	AQ							
	AR							
	AS		<u> </u>					
	AT		(2)					
	AU		· · · · · · · · · · · · · · · · · · ·			<del> </del>		
	AV		<del> </del>			<del> </del>		
	I AV	OTHER PI	EEDENCES !	l Including Author, Title, Date, Pertiner	nt Pages 4	etc.)		
		OTHER RI		moleculing Author, Thie, Date, Fertiller				
	AW							
	AX	,						
	AY							
	AZ				Add	litional Ref	erences s	heet(s) attached
Examiner	/Ge	offrey Evans/	Date Considered 11/24/2007					
*Examiner: to	nitial if	roforence is considered	whether or no	t citation is in conformance with MPEP $\epsilon$ with next communication to applicant.	609; Draw I	ine through	n citation i	f not in